

GP2W3120YP0F

IrDA Compliant Transceiver Module 9.6 kb/s to 4 Mb/s (FIR) Low Profile Low Consumption Current



■ Description

The **GP2W3120YP0F** is an infrared transceiver module for IrDA ver. 1.4 (FIR).

The transceiver consisits of a pin-photo diode, infrared emitter and control IC in a single package.

This device have remote control transmission function.

■Features

1. Compliant with the IrDA 1.4 (FIR)
Transmission speed: 9.6 kb/s to 4 Mb/s
Transmission distance: 20 cm

2. Small package

 $L7.16 \times W2.73 \times H1.82 \text{ mm}$

- 3. Peak emission wavelength: 890 nm (Built-in shared single LED for RC and IrDA)
- 4. Side view type
- 5. Soldering reflow type
- 6. Shield type
- 7. Low consumption current due to shutdown function (Consumption current at shutdown mode: Max. 1.0 μA)
- 8. Operates from 2.7 to 3.3 V
- 9. With remote control function
- 10. With LP/HP mode switching function
- 11. With V_{IO} terminal

■ Agency approvals/Compliance

- 1. Compliant with IEC60825-1 class 1 eye safety standard
- 2. Compliant with RoHS directive (2002/95/EC)
- 3. Content status of six substances specified in "Management Methods for Control of Pollution Caused by Electronic Information Products Regulation" (popular name: *China RoHS*)

(Chinese: 电子信息产品污染控制管理办法)

; refer to page 14

4. Lead (Pb) free device

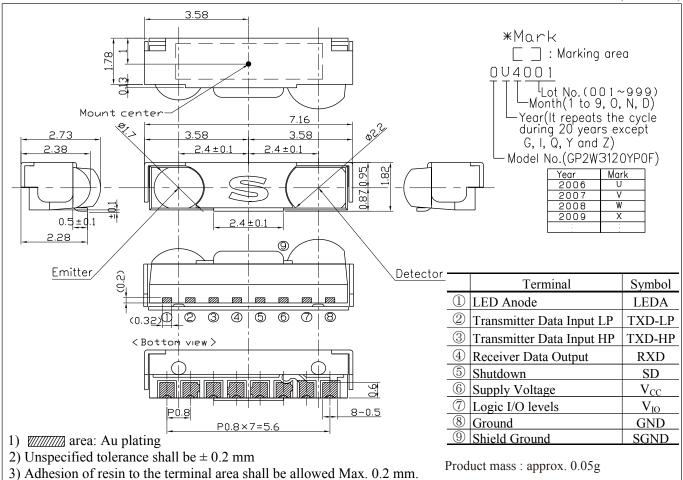
■Applications

- Mobile equipment (Cellular phone, Pager, Smart phone, PDAs, Portable printer, etc.)
- 2. Digital imaging equipment (Digital camera, Photo imaging printer)
- 3. POS equipment
- 4. Personal computers
- 5. Personal information tools



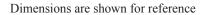
■Block diagram $@V_{CC}$ $@V_{IO}$ Driver Receive Amplifier **4RXD** Detector ①LEDA **AGC** SD⁵ Logic Current controlled driver TXD-LP2 TXD-HP3 **®GND**

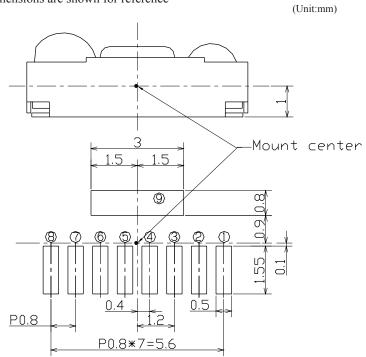
■Outline Dimensions (Unit: mm)





■Recommended PCB Foot Pattern

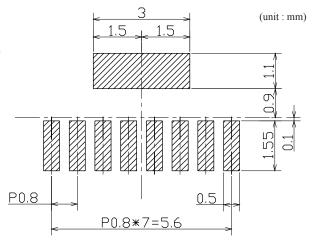




	Terminal	Symbol
1	LED Anode	LEDA
2	Transmitter Data Input LP	TXD-LP
3	Transmitter Data Input HP	TXD-HP
4	Receiver Data Output	RXD
(5)	Shutdown	SD
6	Supply Voltage	V_{CC}
7	Logic I/O levels	V_{IO}
8	Ground	GND
9	Shield Ground	SGND

■ Recommended Size of Solder Creamed Paste (Reference)

Dimensions are shown for reference. Please open the solder mask as below so that the size of solder creamed paste for this device before reflow soldering must be as large as one of the foot pattern land indicated for reference.



: Solder paste area



■ Absolute Maximum Ratings

 $(T_a=25^{\circ}C)$

	Parameter	Symbol	Rating	Unit
Supply	voltage	V _{CC}	-0.3 to 6.0	V
LED Su	ipply voltage	$V_{ m LED}$	-0.3 to 3.6	V
Transm	ission Data Input LP	TXD-LP	-0.3 to V_{CC} +0.3	V
Transm	ission Data Input HP	TXD-HP	-0.3 to V_{CC} +0.3	V
Shut do	wn	SD	-0.3 to $V_{\rm CC}$ +0.3	V
Logic I	O levels	V _{IO}	-0.3 to $V_{\rm CC}$ +0.3	V
*1 Peak fo	rward current	I_{FM}	330	mA
Operati	ng temperature	Topr	-25 to +85	$^{\circ}\!\mathbb{C}$
Storage	temperature	T_{stg}	-40 to +85	$^{\circ}\!\mathbb{C}$
*2 Solderii	ng temperature	T _{sol}	260	$^{\circ}\!\mathbb{C}$

^{*1} Pulse operation (FIR 4 Mb/s)

^{*2} Soldering reflow time : 10 seconds



■Electro-optical Characteristics

(Topr= $25\pm5^{\circ}$ C, Vcc=3.0V Unless otherwise specified)

	-iccti o-opticai	Characteristic	,3	(Topi 23 = 3 C,	100 3.01	C III C 35 C	other wise	specifica)
	Param	eter	Symbol	Rating	MIN.	TYP.	MAX.	Unit
Cu	rent consumption	SIR mode	I _{CC-SIR}	No input signal, V _{ILSD} =0V	_	0.45	0.6	mA
at r	at no input signal FIR mode		I _{CC-FIR}	Output terminal OPEN	_	1.2	1.55	mA
Cui	Current consumption SIR mode		I _{CC-RSIR}	V _{ILSD} =0V	_	0.65	_	mA
at r	at receiving FIR mode		I _{CC-RFIR}	Output terminal OPEN	_	1.3	_	mA
	Current consumption at Transmitting All mode		I _{CC-T}	$V_{IHTXD-LP}$ =High or, $V_{IHTXD-HP}$ =High, V_{ILSD} =0V	_	27	55	mA
	Current consumption at Shutdown mode		I _{CC-S}	No input signal, V _{IHSD} =V _{CC} -1.2V Output terminal OPEN	_	0.01	1.0	μΑ
	High level output v	oltage	V_{OH}	I _{OH} =0.3mA*3	V _{IO} -0.5	V _{IO} -0.3	V _{IO} +0.3	V
	Low level output vo		V_{OL}	$I_{OL}=1 \text{ mA}^{*3}$	_	_	0.6	V
	Rise time		t _r			_	50	ns
	Rise time Fall time		$t_{ m f}$	BR=4Mb/s, C_L =15pF, T_a =25 $^{\circ}$ C*5	_	_	50	ns
			$t_{\rm w1}$		1	_	24	μs
			t _{w2}	$t_{w1}, E_{e1}; BR=9.6kb/s, \phi \leq 15^{\circ}$	1	_	4	μs
	Low level pulse wi	dth	t _{w3}	$t_{w2}, E_{e1}; BR=115.2kb/s, \phi \le 15^{\circ}$	67	_	195	ns
			t _{w4}	$t_{w3}, E_{e2}; BR=4Mb/s(single), \phi \le 15^{\circ}$	190	_	320	ns
iver	Maximum reception	n distance	L	$t_{w4}, E_{e2}; BR=4Mb/s(double), \phi \leq 15^{\circ}$	21	_	_	cm
ece	Maximum reception distance Input irradiance Overload irradiance Receiver Latency Receiver wakeup time SD input current SD terminal Input voltage Logic High		E _{e1}	$T_a=25^{\circ}C$	_	_	8.16	μW/cm ²
R			E _{e2}	Except for pulse	_	_	20.4	$\mu W/cm^2$
			E _{e3}	during a half of preamble	500	_	_	mW/cm ²
			t _l		_	_	500	μs
			t _{sdw}	No input signal	_	_	1	ms
			I _{isd}	V _{IHSD} =V _{CC} , V _{ILSD} =GND	-0.1	0	+0.1	μА
			V _{IHSD}	Shutdown mode	V _{CC} -1.2		V _{CC}	V
	SD terminal Input v		V _{ILSD}	Normal mode	_	_	0.5	V
	Jitter		t _i	BR=4Mb/s, T _a =25°C	_	30	60	ns
		Low power	I _{E-LP}	$V_{LED}=3.3V, R_{LED}=4.3\Omega$ $\phi \le 15^{\circ}, T_{a}=25^{\circ}C^{*4}$	10	_	_	mW/sr
	Radiant intensity	High power	I _{E-HP}	$V_{LED}=3.3V, R_{LED}=4.3\Omega$ $\phi=15^{\circ}, T_{a}=25^{\circ}C^{*4}$	25	_	_	mW/sr
		Low power	I _{LED-LP}		100	150	200	mA
	LED peak current	High power	I _{LED-HP}	V_{LED} =3.3V, R_{LED} =4.3 Ω , T_a =25 $^{\circ}$ C *4	150	250	330	mA
	Rise time		$t_{\rm r}$	*4	_	_	40	ns
er	Fall time		$t_{ m f}$	BR=4Mb/s, V_{LED} =3.3V, T_a =25 $^{\circ}$ C*4	_	_	40	ns
nitt	Fall time Peak emission wave length TXD-LP / TXD-HP high level input voltage		λ_{p}	$T_a=25^{\circ}C$	870	890	900	nm
ansı				$LED(ON), 1.5 \leq V_{IO} \leq 1.8V$	1.4	_	V_{CC}	V
T			V_{IHTXD}	$LED(ON), 1.8 \le V_{IO} \le V_{CC}$	1.6	_	V_{CC}	V
	TXD-LP / TXD-HI low level input vol			LED(OFF)	_	_	0.6	V
	TXD-LP TXD-HP high level input current		I _{IHTXD}	T _a =25°C	_	_	20	μΑ
	TXD-LP TXD-HP low level input curr	rent	I _{ILTXD}	$T_a=25$ °C	_	_	8	μΑ
	Maximum optical p	oulse width	t _{OPWM}	TXD pin stuck high	30	_	300	μs
*2	Refer to Fig. 2, 3							

^{*3} Refer to Fig. 2, 3 *4 Refer to Fig. 4,5,6



■Recommended Operating Conditions

 $(T_a=25^{\circ}C)$

Parameter	Symbol	Conditions	Rating	Unit
Supply voltage	V_{CC}		2.7 to 3.3	V
LED Supply voltage	$V_{ m LED}$	$R_{LED}=4.3\Omega$	2.7 to 3.6	V
Operating temperature	Topr	*5	-25 to +85	$^{\circ}\!\mathbb{C}$
Data rate	BR		9.6k to 4M	b/s
Logic I/O levels	V_{IO}		1.5 to V_{CC}	V

^{*5} When you make Duty 25 % of signal emit light continuously, please use continuation luminescence time in less than 10 seconds.

■Truth Table

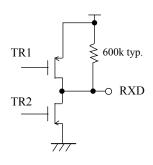
MODE		SD	SW	TXD-LP	TXD-HP	LED	Receiver	TR1	TR2	RXD
Shutdown		Н	Off	L	L	Off	Don't Care	Off	Off	H(Pull-up)
T	LP	L	On	Н	L	LP	Don't Care	Off	On	L(echo)
Transmitter	HP	L	On	L	Н	HP	Don't Care	Off	On	L(echo)
Receiver		L	On	L	L	Off	IrDA Signal	Off	On	L
		L	On	L	L	Off	No Signal	On	Off	Н

H:high, L:Low LP : Low power IE, HP : High power IE

(Note) Don't input Transmitter LP high signal and HP high signal at the same time in transmitter mode.

*RXD equivalent circuit

*TXD equivalent circuit



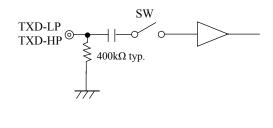
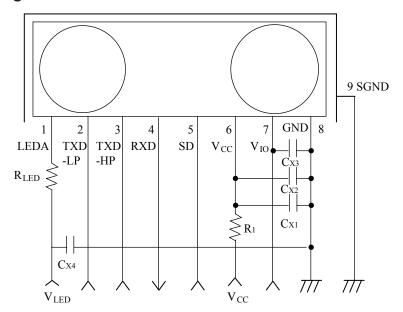




Fig.1 Recommended External Circuit



Comp	onents	Recommended values		
C	X1	4.7μF(Ceramic)(Note1)		
C	X2	0.47μF(Ceramic)(Note1)		
C	X3	0.47μF(Ceramic)(Note1)		
C	X4	10μF(Ceramic)(Note1)		
$R_1(1/16W)$		4.7Ω		
$R_{\rm LED}$ 1/4W		$4.3\Omega(V_{LED}=3.3V)$		
(Note2)	1/10W	$2.4\Omega(V_{LED}=2.85V)$		

(Note1) Components choose the most suitable Cx1, Cx2, Cx3, Cx4 according to the noise level and noise frequency of power supply.

(Nore2) In order to guarantee (10 mW/sr), VLED is required 3.3 V (RLED = 4.3 Ω), VLED is required 2.85 V (RLED = 2.4 Ω).



Fig.2 Output Waveform Specification(Receiver side)

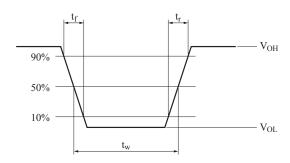
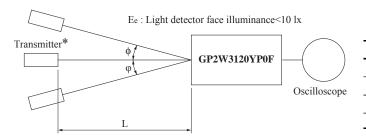
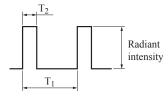


Fig.3 Standard Optical System(Receiver side)



Data rate	T_1	T_2	T_2/T_1	Radiant intensity
9.6kb/s	103μs	19.5µs	3/16	3.6mW/sr
115.2kb/s	8.68µs	1.63µs	3/16	40mW/sr
4Mb/s	500ns	125ns	1/4	9mW/sr
4Mb/s	500ns	250ns	1/2	9mW/sr

* Transmitter shall use the standard transmitter (λ_p = 890 nm TYP.) which is adjusted the radiation intensity at 3.6 mW/sr (at 9.6 to 115.2 kb/s), 9 mW/sr (at 4 Mb/s).



 $[\]boldsymbol{\varphi}$: Indicates horizontal and vertical directions.



Fig.4 Output Waveform Specification(Transmitter side)

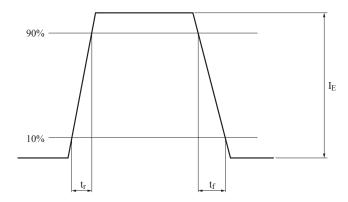


Fig.5 Standard Optical System(Transmitter side)

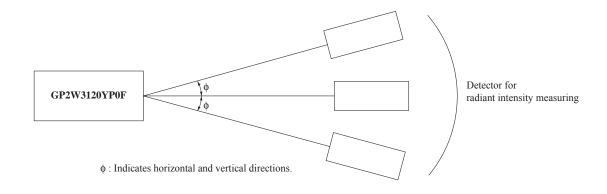


Fig.6 Recommended Circuit of Transmitter side

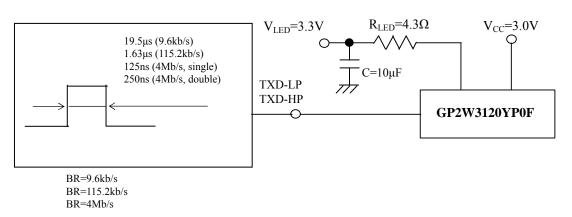
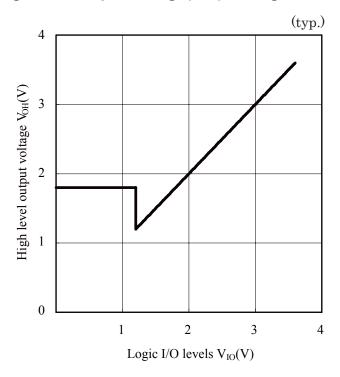




Fig.7 High level output voltage(Voн) vs Logic I/O levels(Vio)



■Notes

- (1) When the system (program) is designed, the Turn Around Time shall be secured by considering $500 \mu s$ or more that is specified to IrDA.
 - Then, this Turn Around Time means the time when this device does not temporarily detect the signal light, since the transmitted light form the transceiver reaches the detector side of the transceiver.
- (2) As it is necessary 1 ms or more (at Ta =25 °C, no input signal) to return from shut-down mode to ready-operation mode, please consider this point at the system (program) designing.

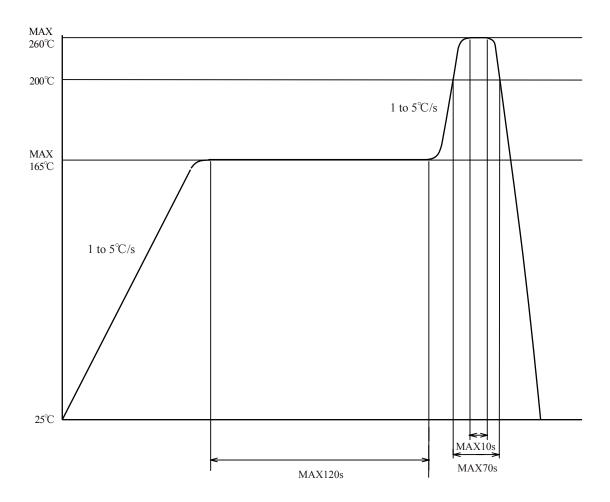
 Also, please confirm thoroughly the operation in actual application.
- (3) When there is much external disturbing light source is located near this transceiver and the detector face resceiver much external disturbing light, there is case that the pulse other than signal output is generated as noise on output terminal of this transceiver. Please consider the lay-out and structure to reduce disturbing light on the detector face.
- (4) In case that this sensor is adopted in IR communication system, please use it according to the signal method which is specified by [Serial Infrared Physical Layer Link Specification Version 1.4] published by Infrared Data Association. False operation may happen if the different signal method is used.
- (5) In circuit designing, make allowance for the degradation of light emitting diode output that results from long continuous operation. (50 % degradation/5 years)



■Soldering Method

1. In case of solder reflow

Please carry out only two times soldering at the temperature and the time within the temperature profile as shown in the figure below. Reflow interval shall be within 3 days under conditions, 10 to 30°C, 70%RH or less.



2. Other precautions

An infrared lamp used to heat up for soldering may cause a localized temperature rise in the resin. So keep the package temperature within that specified in Item 1. Also avoid immersing the resin part in the solder. Even if within the temperature profile above, there is the possibility that the gold wire in package is broken in case that the deformation of PCB gives the affection to lead pins. Please use after confirming the conditions fully by actual solder reflow machine.

3. Soldering

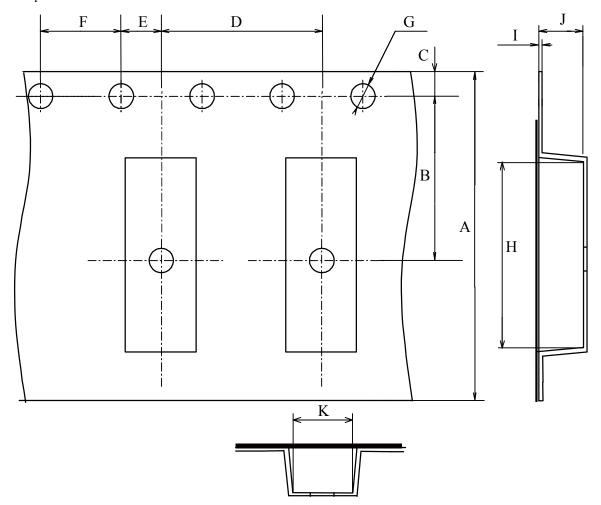
- Soldering iron shall be less than 25W, and temperature of point of soldering iron shall use at 300°C or less.
- Soldering time shall be within 5s.
- Soldered product shall treat at normal temperature.



■Package specification

●Tape and Reel package 2000 pcs/reel

Carrier tape structure and Dimensions

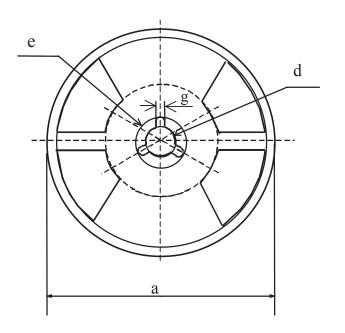


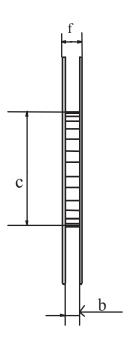
(Unit: mm)

A	В	С	D	Е	F
16.0±0.3	7.5±0.1	1.75±0.1	8.0±0.1	2.0±0.1	4.0±0.1
G	Н	I	J	K	
$\phi \ 1.5^{+0.1}_{-0.0}$	7.45±0.1	0.32±0.05	2.1±0.1	2.8±0.1	



Reel structure and Dimensions



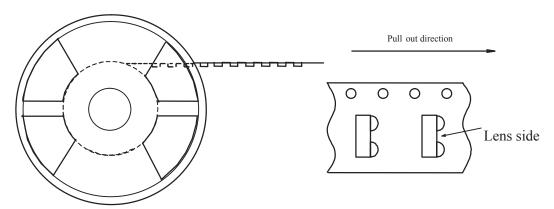


Dimension List

(Unit: mm)

a	b	С	d
φ 330±2	17.5±1.0	φ 100±1	φ 13±0.2
e	f	g	
φ 21±0.8	φ 21±0.8 22.4±1.0		

Direction of product insertion





Cleaning Instructions

Solvent cleaning:

Solvent temperature 45°C or less, Immersion for 3 min or less

Ultrasonic cleaning:

The effect to device by ultrasonic cleaning differs by cleaning bath size, ultrasonic power output, cleaning time, PCB size or device mounting condition etc.

Please test it in actual using condition and confirm that doesn't occur any defect before starting the ultrasonic cleaning. The cleaning shall be carried out with solvent below.

Recommended Solvent materials:

Ethyl alcohol, Methyl alcohol, Isopropyl alcohol

●Presence of ODC etc.

This product shall not contain the following materials.

And they are not used in the production process for this product.

Regulation substances: CFCs, Halon, Carbon tetrachloride, 1.1.1-Trichloroethane (Methylchloroform)

Specific brominated flame retardants such as the PBB and PBDE are not used in this product at all.

• The RoHS directive (2002/95/EC)

This product complies with the RoHS directive (2002/95/EC).

Object substances: lead, cadmium, hexavalent chromium, polybrominated biphenyls (PBB) and polybrominated diphenyl ethers (PBDE)

• Content of six substances specified in "Management Methods for Control of Pollution Caused by Electronic Information Products Regulation" (Chinese: 电子信息产品污染控制管理办法)

	Toxic and hazardous substances					
Category	Lead (Pb)	Mercury (Hg)	Cadmium (Cd)	Hexavalent chromium (Cr ⁶⁺)	Polybrominated biphenyls (PBB)	Polybrominated diphenyl ethers (PBDE)
Infrared data communication device	1	✓	1	1	✓	✓

✓: indicates that the content of the toxic and hazardous substance in all the homogeneous materials of the part is below the concentration limit requirement as described in SJ/T 11363-2006 standard.



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